PHU78NQ03LT

N-channel TrenchMOS logic level FET

Rev. 06 — 15 June 2009 Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Suitable for high frequency applications due to fast switching characteristics
- Suitable for logic level gate drive sources

1.3 Applications

- Computer motherboards
- DC-to-DC convertors

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25$ °C; $T_j \leq 175$ °C	-	-	25	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see Figure 1; see Figure 3	-	-	75	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; see Figure 2	-	-	107	W
Dynamic characteristics						
Q_{GD}	gate-drain charge	V_{GS} = 4.5 V; I_D = 25 A; V_{DS} = 12 V; T_j = 25 °C; see Figure 9; see Figure 10	-	4	-	nC
Static characteristics						
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; see Figure 7; see Figure 8	-	7.65	9	mΩ

NXP founded by Philips

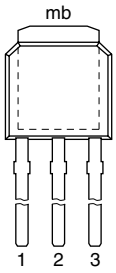
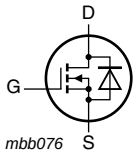
2. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
PHU78NQ03LT	IPAK	plastic single-ended package (IPAK); 3 leads (in-line)	SOT533

3. Pinning information

Table 3. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	 SOT533 (IPAK)	
2	D	drain		
3	S	source		
mb	D	mounting base; connected to drain		

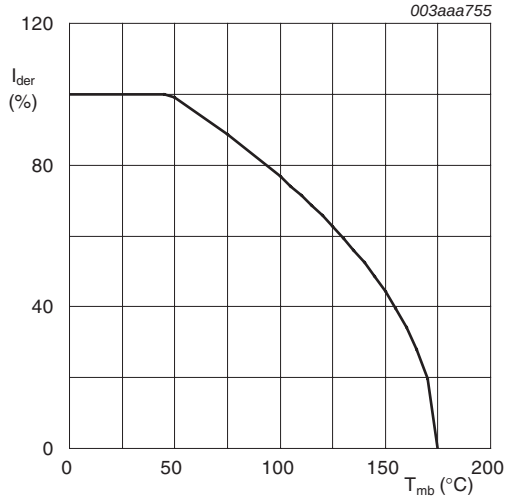
© NXP B.V. 2009. All rights reserved.

4. Limiting values

Table 4. Limiting values

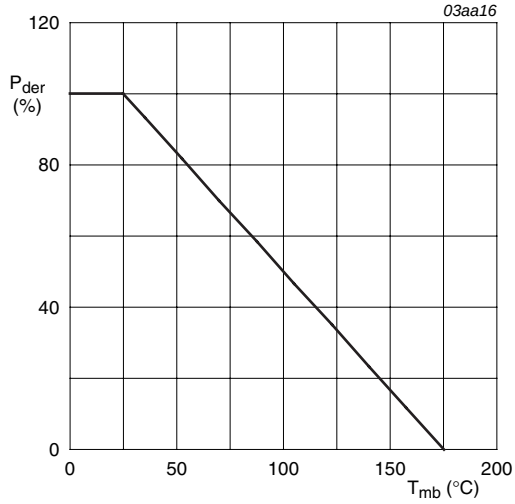
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25$ °C; $T_j \leq 175$ °C	-	25	V
V_{DGR}	drain-gate voltage	R_{GS} = 20 kΩ; $T_{mb} \geq 25$ °C; $T_{mb} \leq 175$ °C	-	25	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	V_{GS} = 5 V; T_{mb} = 100 °C	-	46.9	A
		V_{GS} = 10 V; T_{mb} = 100 °C; see Figure 1	-	57.5	A
		V_{GS} = 10 V; T_{mb} = 25 °C; see Figure 1; see Figure 3	-	75	A
		V_{GS} = 5 V; T_{mb} = 25 °C	-	66.4	A
I_{DM}	peak drain current	$t_p \leq 10$ µs; pulsed; T_{mb} = 25 °C; see Figure 3	-	240	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; see Figure 2	-	107	W
T_{stg}	storage temperature		-55	175	°C
T_j	junction temperature		-55	175	°C
Source-drain diode					
I_S	source current	T_{mb} = 25 °C	-	75	A
I_{SM}	peak source current	$t_p \leq 10$ µs; pulsed; T_{mb} = 25 °C	-	240	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 32 A; $V_{sup} \leq 25$ V; unclamped; t_p = 0.17 ms; R_{GS} = 50 Ω	-	100	mJ



$$I_{der} = \frac{I_D}{I_{D(25°C)}} \times 100\,\%$$

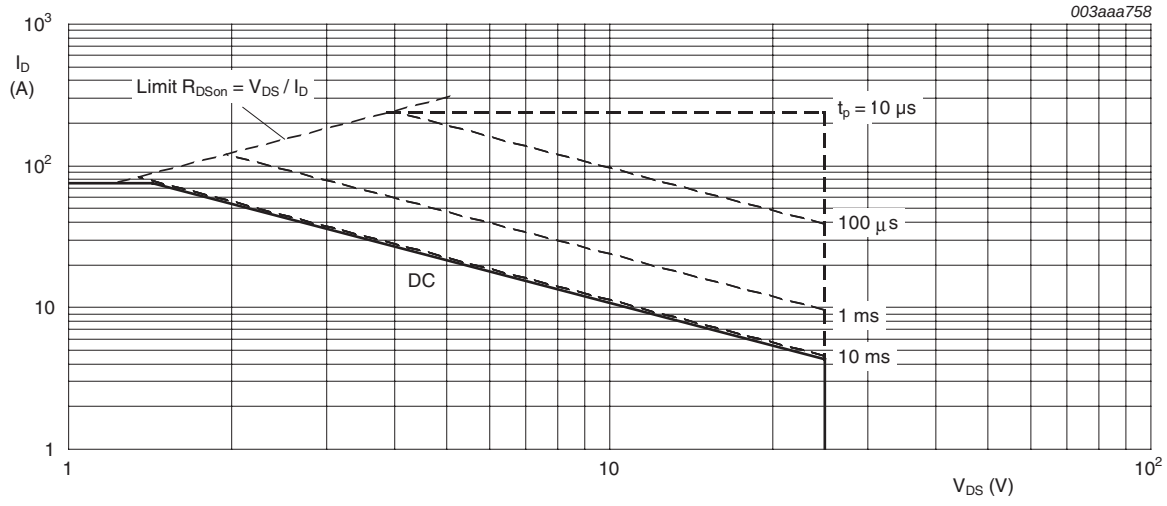
Fig 1. Normalized continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25°C)}} \times 100\,\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature

© NXP B.V. 2009. All rights reserved.



$T_{mb} = 25°C; I_{DM}$ is single pulse; $V_{GS} = 10V$

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	1.4	K/W
$R_{th(j\text{-}a)}$	thermal resistance from junction to ambient	vertical in free air	-	70	-	K/W

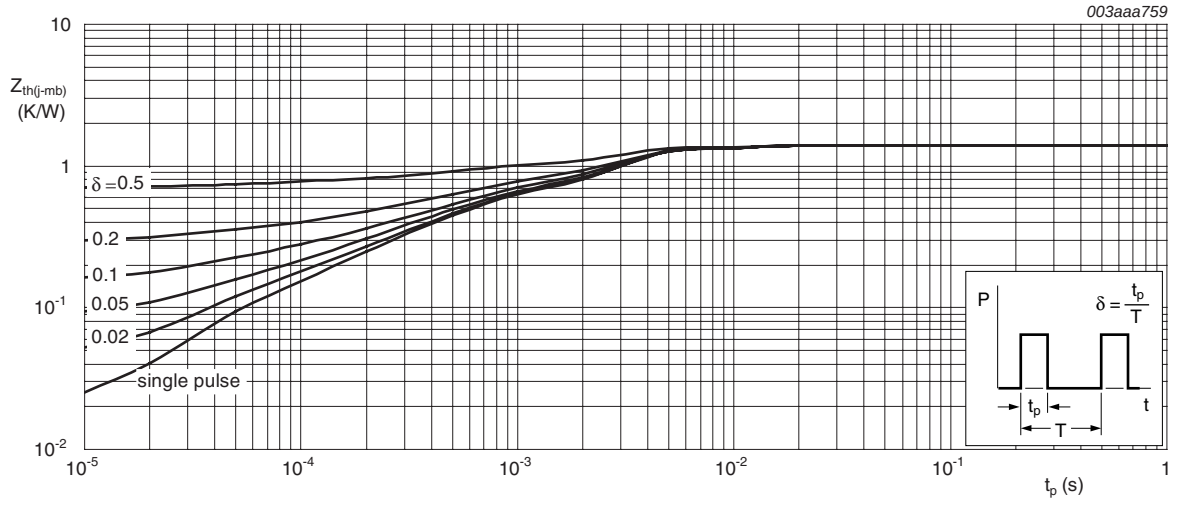


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

© NXP B.V. 2009. All rights reserved.

6. Characteristics

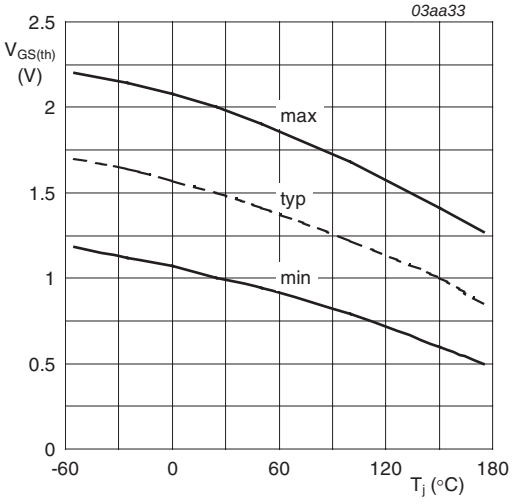
Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	22	-	-	V
		I_D = 250 µA; V_{GS} = 0 V; T_j = 25 °C	25	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55 °C; see Figure 5; see Figure 6	-	-	2.2	V
		I_D = 1 mA; V_{DS} = V_{GS}; T_j = 175 °C; see Figure 5; see Figure 6	0.5	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25 °C; see Figure 5; see Figure 6	1	1.5	2	V
I_{DSS}	drain leakage current	V_{DS} = 25 V; V_{GS} = 0 V; T_j = 25 °C	-	-	1	µA
		V_{DS} = 25 V; V_{GS} = 0 V; T_j = 175 °C	-	-	500	µA
I_{GSS}	gate leakage current	V_{GS} = 15 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = -15 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; see Figure 7; see Figure 8	-	7.65	9	mΩ
		V_{GS} = 5 V; I_D = 25 A; T_j = 175 °C; see Figure 7; see Figure 8	-	18.9	24.3	mΩ
		V_{GS} = 5 V; I_D = 25 A; T_j = 25 °C; see Figure 7; see Figure 8	-	10.5	13.5	mΩ
R_G	internal gate resistance (AC)	f = 1 MHz; T_j = 25 °C	-	1	-	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	I_D = 0 A; V_{DS} = 0 V; V_{GS} = 4.5 V; T_j = 25 °C	-	8.6	-	nC
		I_D = 25 A; V_{DS} = 12 V; V_{GS} = 4.5 V; T_j = 25 °C; see Figure 9; see Figure 10	-	11	-	nC
Q_{GS}	gate-source charge	I_D = 25 A; V_{DS} = 12 V; V_{GS} = 4.5 V; T_j = 25 °C; see Figure 10; see Figure 10	-	3.6	-	nC
Q_{GS1}	pre-threshold gate-source charge		-	1.8	-	nC
Q_{GS2}	post-threshold gate-source charge		-	1.8	-	nC
Q_{GD}	gate-drain charge		-	4	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	I_D = 25 A; V_{DS} = 12 V; T_j = 25 °C; see Figure 9; see Figure 10	-	3	-	V
C_{iss}	input capacitance	V_{DS} = 12 V; V_{GS} = 0 V; f = 1 MHz; T_j = 25 °C; see Figure 11	-	970	-	pF
			-	1460	-	pF
C_{oss}	output capacitance		-	415	-	pF
C_{rss}	reverse transfer capacitance		-	170	-	pF

© NXP B.V. 2009. All rights reserved.

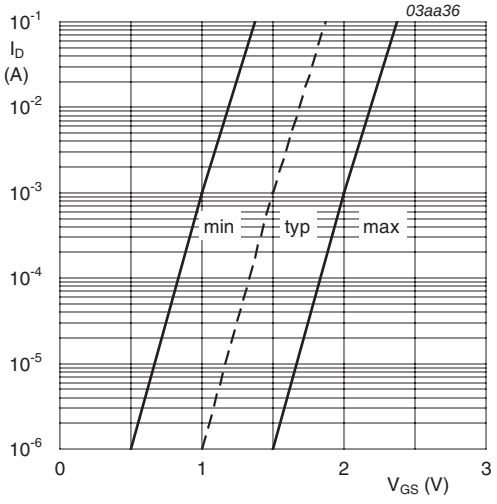
Table 6. Characteristics *...continued*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	turn-on delay time	V_{DS} = 12 V; R_L = 0.5 Ω; V_{GS} = 5 V; $R_{G(ext)}$ = 5.6 Ω; T_j = 25 °C	-	13	-	ns
t_r	rise time		-	46	-	ns
$t_{d(off)}$	turn-off delay time		-	20	-	ns
t_f	fall time		-	15	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	I_S = 25 A; V_{GS} = 0 V; T_j = 25 °C; see Figure 12	-	0.78	1.2	V
t_{rr}	reverse recovery time	I_S = 20 A; dI_S/dt = -100 A/µs; V_{GS} = 0 V; V_{DS} = 25 V; T_j = 25 °C	-	35	-	ns
Q_r	recovered charge		-	20	-	nC



$I_D = 1\,mA; V_{DS} = V_{GS}$

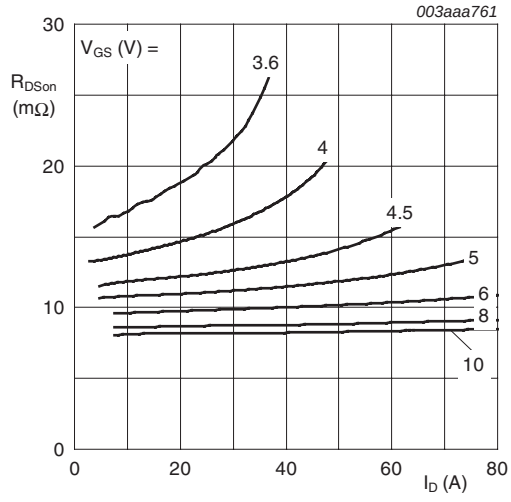
Fig 5. Gate-source threshold voltage as a function of junction temperature



$T_j = 25\,°C; V_{DS} = V_{GS}$

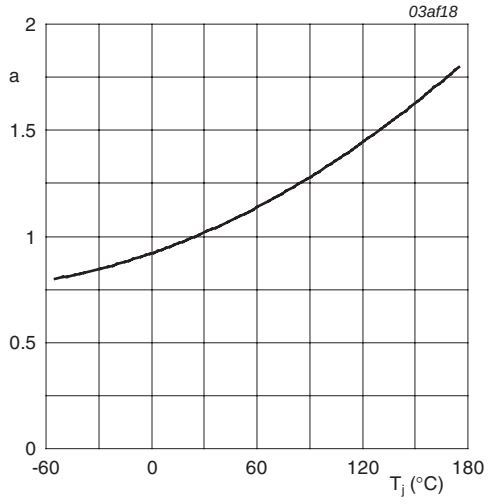
Fig 6. Sub-threshold drain current as a function of gate-source voltage

© NXP B.V. 2009. All rights reserved.



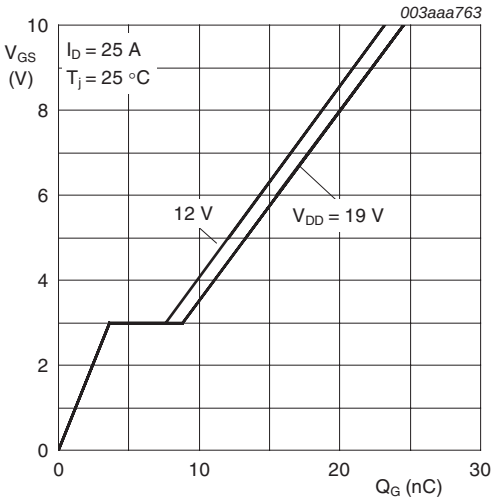
$T_j = 25°C$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values



$$a = \frac{R_{DSon}}{R_{DSon(25°C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



$I_D = 25A; V_{Ds} = 12V \text{ and } 19V$

Fig 9. Gate-source voltage as a function of gate charge; typical values

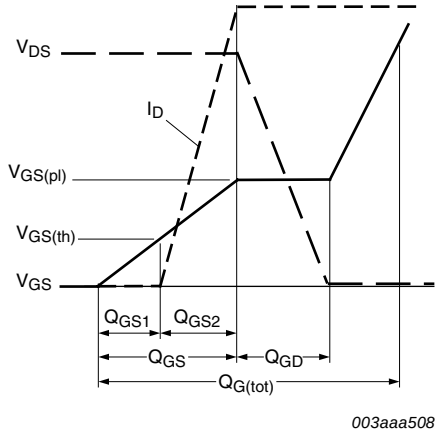
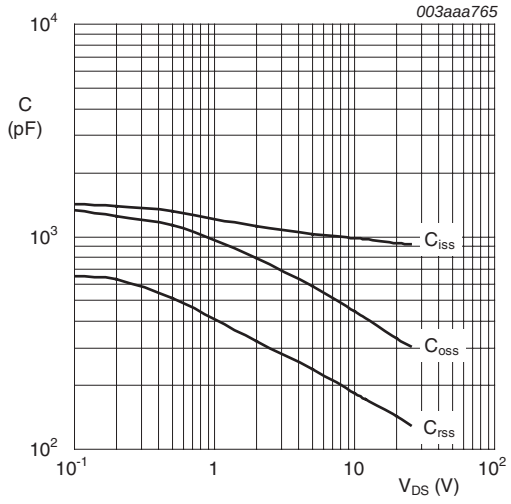


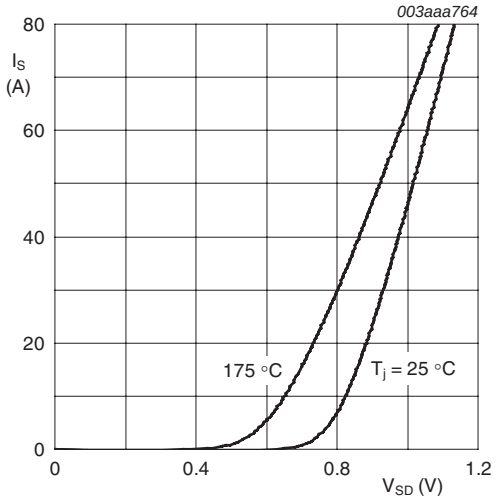
Fig 10. Gate charge waveform definitions

© NXP B.V. 2009. All rights reserved.



$V_{GS} = 0V; f = 1MHz$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



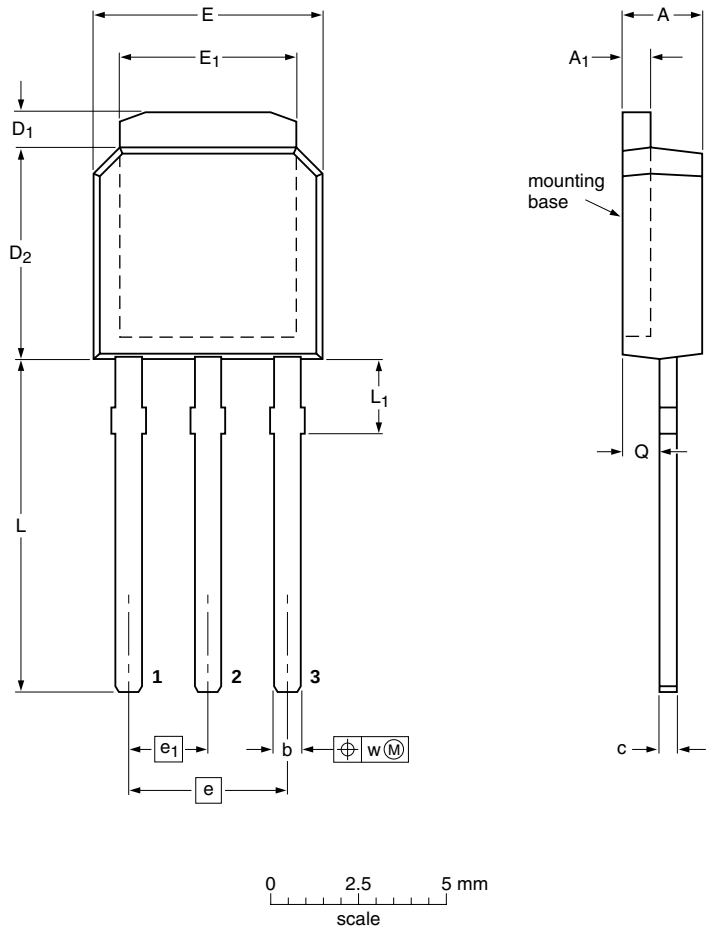
$T_j = 25°C \text{ and } 175°C; V_{GS} = 0V$

Fig 12. Source current as a function of source-drain voltage; typical values

© NXP B.V. 2009. All rights reserved.

7. Package outline

Plastic single-ended package (IPAK); 3 leads (in-line) **SOT533**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	c	D_1	D_2	E	E_1	e	e_1	L	L_1 (2) max	Q	w
mm	2.38 2.22	0.93 0.46	0.89 0.71	0.56 0.46	1.10 0.96	6.22 5.98	6.73 6.47	5.21 5.00	4.57 BSC (1)	2.285 BSC (1)	9.6 9.2	2.7	1.1 1.0	0.3

Notes

1. Basic spacing between centers.
2. Terminal dimensions are uncontrolled within zone L_1.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT533		TO-251				~~05-02-11~~ 06-02-14

Fig 13. Package outline SOT533 (IPAK)

© NXP B.V. 2009. All rights reserved.

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHU78NQ03LT_6	20090615	Product data sheet	-	PHU_PHD78NQ03LT_5
Modifications:	• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. • Legal texts have been adapted to the new company name where appropriate. • Type number PHU78NQ03LT separated from data sheet PHU_PHD78NQ03LT_5.			
PHU_PHD78NQ03LT_5 (9397 750 15084)	20050727	Product data sheet	-	PHP_PHU78NQ03LT_4
PHP_PHU78NQ03LT_4 (9397 750 13431)	20040726	Product data sheet	-	PHP_PHB_PHD78NQ03LT-03
PHP_PHB_PHD78NQ03LT-03 (9397 750 09667)	20020626	Product data	-	PHP_PHB_PHD78NQ03LT-02
PHP_PHB_PHD78NQ03LT-02 (9397 750 09418)	20020322	Product data	-	PHP_PHB_PHD78NQ03LT-01
PHP_PHB_PHD78NQ03LT-01 (9397 750 08916)	20011114	Product data	-	-

© NXP B.V. 2009. All rights reserved.

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

9.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

9.3 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

9.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

TrenchMOS — is a trademark of NXP B.V.

10. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

© NXP B.V. 2009. All rights reserved.

11. Contents

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2009. **All rights reserved.**

For more information, please visit: http://www.nxp.com
For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 15 June 2009
Document identifier: PHU78NQ03LT_6

founded by

PHILIPS